Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/087,234	KUMAR ET AL.	
Examiner	Art Unit	
Joon H. Hwang	2166	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

(INCLUDING SEARCH	SIRAIEGY	)
	DATE	EXMR
Inventor searched see search history printout(s) consulted Pat Salce for double patent	11/1/2006	JH
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